Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/651,062	AOKI ET AL.	
Examiner	Art Unit	
Christopher M. Keehan	1712	

	 				
SEARCHED					
Class	Subclass	Date	Examiner		
428	447	3/28/2005	СМК		
313	506				
	498				

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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	3/28/2005	CMK		
Inventor name search				
10/337307, 09/789748				